

Notice of References Cited			Application/Control No. 10/776,433	Applicant(s)/Patent Under Reexamination REN ET AL.	
			Examiner Patricia Leith	Art Unit 1655	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,005,108	01-1977	Kupchan et al.	549/297
*	B	US-5,192,817	03-1993	Takaishi et al.	549/298
*	C	US-5,430,054	07-1995	Qian et al.	514/468
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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